

**Search Notes**

Application/Control No.

10/651,524

Examiner

Gopal C. Ray

Applicant(s)/Patent under  
Reexamination

DENG ET AL.

Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	306,315,1 00,313,52, 305,5,33	6/20/2005	GCR
712	32	6/20/2005	GCR
709	253	6/21/2005	GCR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB	5/31/2005	GCR
EAST: USPT	5/31/2005	GCR
NPL; IEEE Xplore	5/31/2005	GCR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB	6/20/2005	GCR